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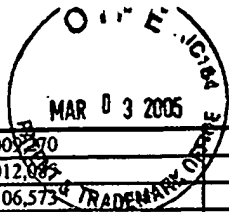
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Substitute for form 1449A/PTO <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (use as many sheets as necessary)			<i>Complete if Known</i>		
			Application Number	09/844,668	
			Filing Date	April 30, 2001	
			First Named Inventor	THEKKATH	
			Group Art Unit	2122-92	
			Examiner Name	Pham, Chrystine	
Sheet	1	of	2	Attorney Docket Number	MTEC-004/00US

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY
		Number	Kind Code <sup>2</sup> (if known)		
CP	P1	3,473,154		Couleur et al.	10/14/1969
	P2	3,585,599		Hitt	06/15/1971
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<sup>1</sup> Unique citation designation number.

<sup>2</sup> See attached Kinds of U.S. Patent Documents.



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FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY
		Office <sup>1</sup>	Number <sup>2</sup>	Kind Code <sup>3</sup> (if known)		
CP	F1	GB	2 329 048		ARM Limited	10/03/1999
CP	F2	GB	2 329 049		ARM Limited	10/03/1999

Examiner Signature		Date Considered	05/31/05
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<sup>1</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3).

<sup>2</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

<sup>3</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible.

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PTO/SB/08A (08-00)

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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
CA	D1	Embedded Trace Macrocell Specification, Rev. 0/0a, ARM IHI 0014C, ARM Ltd. (1999)	

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